

Notice of References Cited	Application/Control No. 09/883,851		Applicant(s)/Patent Under Reexamination MAGLICH, BOGDAN C.	
	Examiner Daniel L. Greene Jr.		Art Unit 3663	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,968,907	11-1990	Pepper, Brian T.	327/286
	B	US-5,378,895	01-1995	Cole et al.	250/390.04
	C	US-5,206,174	04-1993	Gehrke et al.	436/58
	D	US-5,198,816	03-1993	Kalinowski et al.	341/137
	E	US-5,821,533	10-1998	Bingham et al.	250/252.1
	F	US-5,995,989	11-1999	Gedcke et al.	708/300
	G	US-5,150,317	09-1992	Countryman, Lauren P.	708/300
	H	US-5,428,357	06-1995	Haab et al.	341/155
	I	US-5,592,402	01-1997	Beebe et al.	703/6
	J	US-6,006,167	12-1999	Bunting, John E.	702/130
	K	US-6,069,936	05-2000	Bjorkholm, Paul J.	378/98.9
	L	US-4,797,619	01-1989	Austin et al.	324/409
	M	US-5,109,227	04-1992	Godfrey, Wesley L.	340/600

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Current Status of the Associated Particle Imaging system at STL, Hurley et al., January 10, 1992; EGG-10617-3008, pp 1-45			
	V	Publications, last accessed 8/10/2005, available @ http://www.silcom.com/~drlny/publications.htm			
	W	Design of an Associated Particle Imaging System, Beyerle, et al., Nuclear Instruments and Methods in Physics Research, A299 pp 458-462 (1990)			
	X	Data Simulation for the Associated Particle Imaging System, L.N. Tunnell, EGG 11265-3007 UC-905, June 02, 1994			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,916,313	04-1990	Hall et al.	250/282
	B	US-4,724,118	02-1988	Grenier, Gerard	376/159
	C	US-4,931,646	06-1990	Koechner et al.	250/367
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Abstract, Charged particles spectrometer-identifier, Tashk Univ 16.06.88-SU-443603 (15.10.90) G01t-01/38
	V	HiEnergy Technologies, Inc. (HEIT) company interview, The Wall Street Transcript, accessed 8/10/2005, available @ http://www.hienergyinc.com/press/articles/WallStreetTranscript040405.pdf
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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